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FDB8896

N-Channel PowerTrench[®] MOSFET 30V, 93A, 5.7m Ω

General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low $r_{DS(ON)}$ and fast switching speed.

Applications

- DC/DC converters

GATE SOURCE TO-263AB FDB SERIES



· High power and current handling capability

• $r_{DS(ON)} = 5.7 m\Omega$, $V_{GS} = 10V$, $I_D = 35A$

• $r_{DS(ON)} = 6.8m\Omega$, $V_{GS} = 4.5V$, $I_D = 35A$

· High performance trench technology for extremely low

Features

r_{DS(ON)}

· Low gate charge

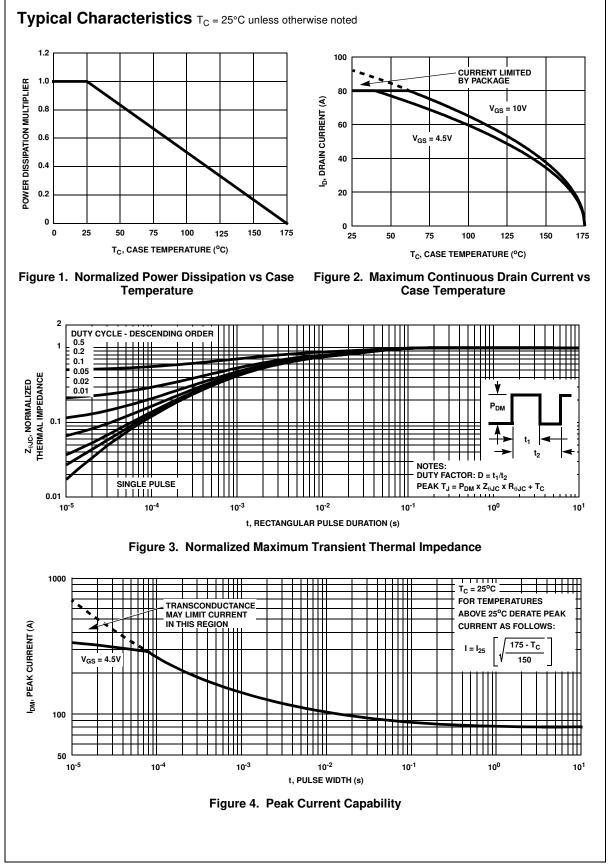
MOSFET Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter				Ratings	Units
V _{DSS}	Drain to Source Voltage			30	V	
V _{GS}	Gate to Source Voltage			±20	V	
ID	Drain Current					
	Continuous (T _C = 25 ^o C, V _{GS} = 10V) (Note 1)				93	A
	Continuous ($T_c = 25^{\circ}C$, $V_{GS} = 4.5V$) (Note 1)				85	A
	Continuous ($T_{amb} = 25^{\circ}C$, $V_{GS} = 10V$, with $R_{\theta JA} = 43^{\circ}C/W$)				19	А
	Pulsed				Figure 4	A
E _{AS}	Single Pulse Avalanche Energy (Note 2)			74	mJ	
P _D	Power dissipation				80	W
	Derate above 25°C				0.53	W/ºC
T _J , T _{STG}	Operating and Storage Temperature			-55 to 175	°C	
R _{θJC}		sistance Junction to		oto 2)	1.88	°C/W
R _{θJA}	Thermal Resistance Junction to Ambient TO-263 (Note 3)					°C/W
$R_{\theta JA}$	Thermal Resistance Junction to Ambient TO-263, 1in ² copper pad area				43 0	
Package		g and Orderir	ng Informatio	n Reel Size	Tape Width	Quantity
FDB8	ů.	FDB8896	TO-263AB	330mm	24mm	800 units
	000	1 000000	10-203AD	33011111	2411111	

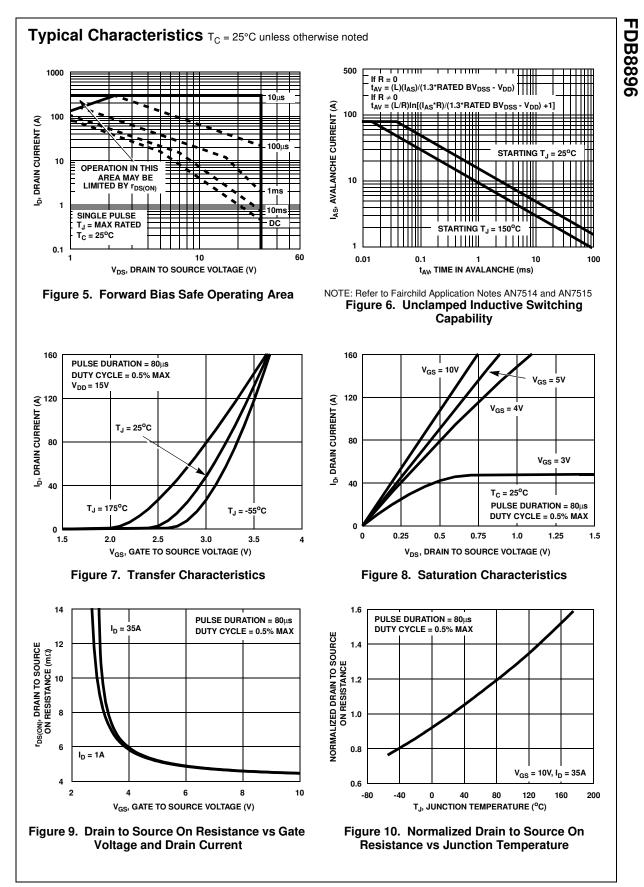
May 2008

FDB8896

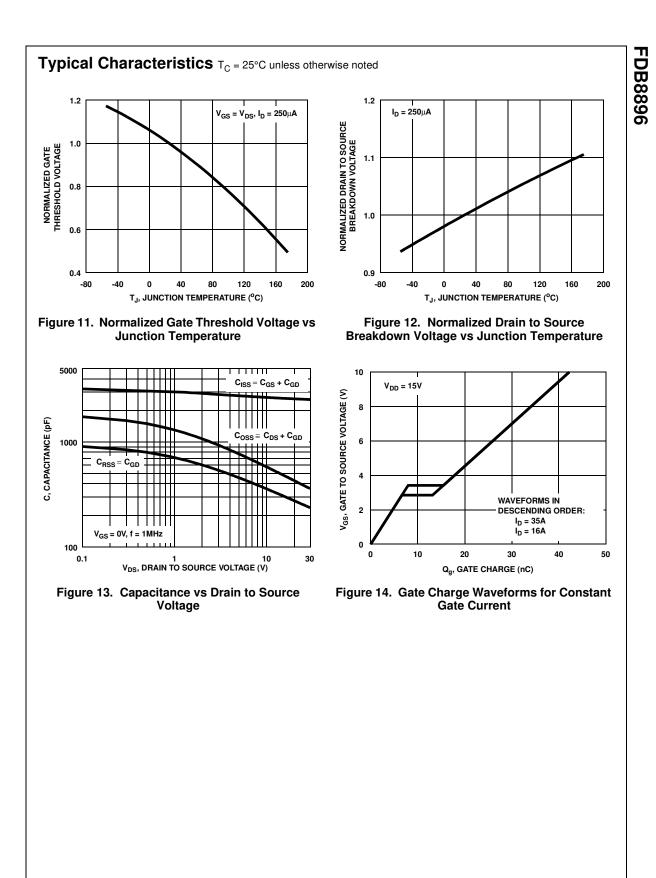
Parameter	Test Conditions		Тур	Max	Units
octeristics					
	$I_{\rm D} = 250 \mu A$, $V_{\rm OO} = 0 V$	30	-	-	V
-		-	-	1	-
Zero Gate Voltage Drain Current		-	-	250	μA
Gate to Source Leakage Current	V _{GS} = ±20V	-	-	±100	nA
cteristics		•			
	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	1.2	-	2.5	V
		-	0.0049	0.0057	Ω
		-	0.0059	0.0068	
Drain to Source On Resistance	I _D = 35A, V _{GS} = 10V,	-			
	$1_{j} = 1/5^{-}$ C				
			0-0-		
	$V_{DS} = 15V. V_{CS} = 0V.$		-		pF
	= f = 1 MHz				pF
· · · · · · · · · · · · · · · · · · ·					pF
	0.0				Ω
		-	-		nC
	$V_{GS} = 0V$ to 5V		-		nC
	$V_{GS} = 0V \text{ to } 1V$ $V_{DD} = 13V$	-	2.3	3.0	nC
č	$I_{g} = 1.0$ mA	-	8	-	nC
Gate Charge Threshold to Plateau	9	-	5.7	-	nC
Gate to Drain "Miller" Charge		-	9.5	-	nC
g Characteristics (V _{GS} = 10V)					
Turn-On Time		-	-	167	ns
Turn-On Time		-	- 9	167	
Turn-On Time Turn-On Delay Time	 		9	167 -	ns
Turn-On Time Turn-On Delay Time Rise Time	V _{DD} = 15V, I _D = 35A V _{GS} = 4.5V, R _{GS} = 6.2Ω	-	9 102	-	ns ns
Turn-On Time Turn-On Delay Time Rise Time Turn-Off Delay Time	V _{DD} = 15V, I _D = 35A V _{GS} = 4.5V, R _{GS} = 6.2Ω	-	9 102 58	-	ns ns ns
Turn-On TimeTurn-On Delay TimeRise TimeTurn-Off Delay TimeFall Time		-	9 102		ns ns ns ns
Turn-On Time Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn-Off Time			9 102 58 44		ns ns ns
Turn-On TimeTurn-On Delay TimeRise TimeTurn-Off Delay TimeFall Time	V _{GS} = 4.5V, R _{GS} = 6.2Ω	- - - -	9 102 58 44 -	- - - 153	ns ns ns ns
Turn-On Time Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn-Off Time	V _{GS} = 4.5V, R _{GS} = 6.2Ω		9 102 58 44 -	- - - 153	ns ns ns ns V
Turn-On Time Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn-Off Time urce Diode Characteristics	V _{GS} = 4.5V, R _{GS} = 6.2Ω	- - - -	9 102 58 44 -	- - - 153	ns ns ns ns
	cteristics Gate to Source Threshold Voltage Drain to Source On Resistance Characteristics Input Capacitance Output Capacitance Gate Resistance Total Gate Charge at 10V Total Gate Charge at 5V Threshold Gate Charge Gate to Source Gate Charge Gate Charge Threshold to Plateau	$\begin{tabular}{ c c c c } \hline Drain to Source Breakdown Voltage & I_D = 250 \mu A, V_{GS} = 0V \\ \hline V_{DS} = 24V \\ \hline V_{GS} = 0V & T_C = 150^\circ C \\ \hline Gate to Source Leakage Current & V_{GS} = \pm 20V \\ \hline \hline Cteristics \\ \hline Gate to Source Threshold Voltage & V_{GS} = \pm 20V \\ \hline \hline Cteristics \\ \hline Gate to Source On Resistance & I_D = 35A, V_{GS} = 10V \\ \hline I_D = 35A, V_{GS} = 10V \\ \hline I_D = 35A, V_{GS} = 10V, \\ \hline I_D = 35A, V_{GS} = 10V, \\ \hline I_J = 175^\circ C \\ \hline \hline Characteristics \\ \hline Input Capacitance & V_{DS} = 15V, V_{GS} = 0V, \\ \hline f = 1MHz \\ \hline Reverse Transfer Capacitance & V_{GS} = 0.5V, f = 1MHz \\ \hline Total Gate Charge at 10V & V_{GS} = 0V to 10V \\ \hline Threshold Gate Charge & V_{GS} = 0V to 1V \\ \hline I_D = 35A, V_{GS} = 0V to 1V \\ \hline I_D = 35A, V_{GS} = 10V, \\ \hline I_D = 35A, V_{GS} = 0V to 10V \\ \hline I_D = 35A, V_{GS} = 0V to 10V \\ \hline I_D = 35A, \\ \hline $	$\begin{tabular}{ c c c c } \hline Drain to Source Breakdown Voltage $I_D = 250 \mu A$, $V_{GS} = 0V$ 30$ \\ \hline Zero Gate Voltage Drain Current $V_{DS} = 24V$ $-$ \\ \hline V_{GS} = 0V$ $$ $T_C = 150^\circ C$ $-$ \\ \hline Gate to Source Leakage Current $V_{GS} = \pm 20V$ $-$ \\ \hline \hline Gate to Source Threshold Voltage $V_{GS} = \pm 20V$ $-$ \\ \hline \hline Cteristics $$ \\ \hline Gate to Source Threshold Voltage $V_{GS} = V_{DS}, I_D = 250 \mu A$ 1.2 \\ \hline I_D = 35A, $V_{GS} = 10V$ $-$ \\ \hline I_D = 35A, $V_{GS} = 10V$ $-$ \\ \hline I_D = 35A, $V_{GS} = 10V$ $-$ \\ \hline I_D = 35A, $V_{GS} = 10V$ $-$ \\ \hline I_D = 35A, $V_{GS} = 10V$ $-$ \\ \hline I_D = 35A, $V_{GS} = 10V$ $-$ \\ \hline I_D = 35A, $V_{GS} = 10V$ $-$ \\ \hline I_D = 35A, $V_{GS} = 10V$ $-$ \\ \hline I_D = 35A, $V_{GS} = 10V$ $-$ \\ \hline I_D = 35A, $V_{GS} = 0V$, $-$ \\ \hline I_D = 35A, $V_{GS} = 0V$, $-$ \\ \hline I_D = 35A, $V_{GS} = 0V$, $-$ \\ \hline I_D = 35A, $V_{GS} = 0V$, $-$ \\ \hline I_D = 35A, $V_{GS} = 0V$, $-$ \\ \hline I_D = 35A, $V_{GS} = 0V$, $-$ \\ \hline I_D = 35A, $V_{GS} = 0V$, $-$ \\ \hline I_D = 35A, $V_{GS} = 0V$, $-$ \\ \hline I_D = 35A, $V_{GS} = 0V$, $-$ \\ \hline I_D = 35A, $V_{GS} = 0V$, $-$ \\ \hline I_D = 35A, $V_{GS} = 0V$, $-$ \\ \hline I_D = 35A, $V_{GS} = 0V$, $-$ \\ \hline I_D = 35A, $V_{GS} = 0V$, $-$ \\ \hline I_D = 35A, $V_{GS} = 0V$, $-$ \\ \hline I_D = 35A, $V_{GS} = 0V$, $-$ \\ \hline I_D = 35A, $V_{GS} = 0V$, $010V$ $-$ \\ \hline I_D = 35A, $V_{GS} = 0V$, $010V$ $-$ \\ \hline I_D = 35A, $V_{GS} = 0V$ \\ \hline I_D = 35A, $V_{GS} = 0V$ \\ \hline I_D = 35A, $V_{GS} = 0V$ \\ \hline I_D = 35A, $V_{DD} = 15V$ $-$ \\ \hline I_D = 35A, $I_g = 1.0mA$ $-$ \\ \hline I_D = 35A, $I_g = 1.0mA$ $-$ \\ \hline I_D = 35A, $I_g = 1.0mA$ $-$ \\ \hline I_D = 35A, $I_g = 1.0mA$ $-$ \\ \hline I_D = 35A, $I_g = 1.0mA$ $-$ \\ \hline I_D = 35A, $I_{S} = 1.0mA$ $-$ \\ \hline I_D = 35A, $I_{S} = 1.0mA$ $-$ \\ \hline I_D = 35A, $I_{S} = 1.0mA$ $-$ \\ \hline I_D = 35A, $I_{S} = 1.0mA$ $-$ \\ \hline I_D = 35A, $I_{S} = 1.0mA$ $-$ \\ \hline I_D = 35A, $I_{S} = 1.0mA$ $-$ \\ \hline I_D = 35A, $I_{S} = 1.0mA$ $-$ \\ \hline I_D = 35A, $I_{S} = 1.0mA$ $-$ \\ \hline I_D = 35A, $I_{S} = 1.0mA$ $-$ \\ \hline I_D = 35A, $I_{S} = 1.0mA$ $-$ \\ \hline I_D = 35A, $I_{S} = 1.0mA$ $-$ \\ \hline I_D = 35A, $I_{S} = 1.0mA$ $-$ \\ \hline I_D = 35A, $I_{S} = 1.0mA$ $-$ $	$\begin{array}{ c c c c } \hline Drain to Source Breakdown Voltage} & I_D = 250 \mu A, V_{GS} = 0V & 30 & - & - & - & - & - & - & - & - & - & $	$\begin{array}{c c c c c c c } \hline Drain to Source Breakdown Voltage & I_D = 250 \mu A, V_{GS} = 0V & 30 & - & - & 1 \\ \hline V_{DS} = 24V & & - & - & 1 \\ \hline V_{GS} = 0V & T_C = 150^{\circ}C & - & - & 250 \\ \hline Gate to Source Leakage Current & V_{GS} = \pm 20V & - & - & \pm 100 \\ \hline \hline Cteristics & & & & & & & & \\ \hline Gate to Source Threshold Voltage & V_{GS} = V_{DS}, I_D = 250 \mu A & 1.2 & - & 2.5 \\ \hline Drain to Source On Resistance & & & & & & & & & \\ \hline I_D = 35A, V_{GS} = 10V & - & 0.0049 & 0.0057 \\ \hline I_D = 35A, V_{GS} = 4.5V & - & 0.0059 & 0.0068 \\ \hline I_D = 35A, V_{GS} = 10V, & - & 0.0078 & 0.0094 \\ \hline \hline Drain to Source On Resistance & & & & & & & \\ \hline I_D = 35A, V_{GS} = 10V, & - & 0.0078 & 0.0094 \\ \hline \hline Characteristics & & & & & & & & & \\ \hline Input Capacitance & & & & & & & & & & & & & \\ \hline Input Capacitance & & & & & & & & & & & & & & & & & & \\ \hline Input Capacitance & & & & & & & & & & & & & & & & & & &$



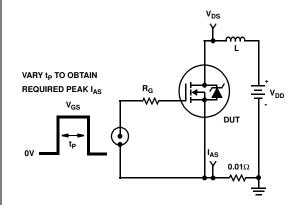
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Test Circuits and Waveforms



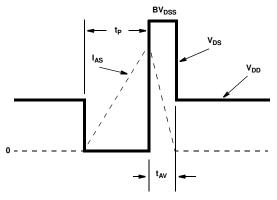


Figure 15. Unclamped Energy Test Circuit

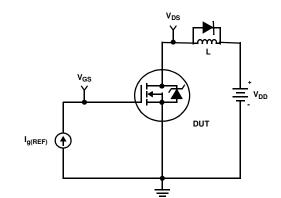


Figure 17. Gate Charge Test Circuit

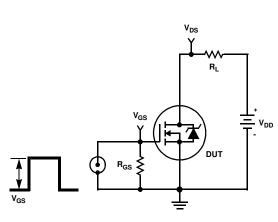


Figure 19. Switching Time Test Circuit



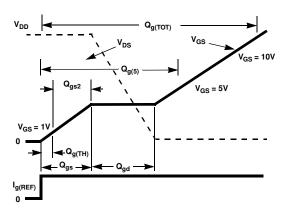
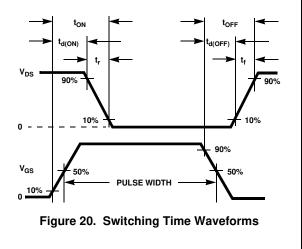


Figure 18. Gate Charge Waveforms



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Thermal Resistance vs. Mounting Pad Area

The maximum rated junction temperature, T_{JM} , and the thermal resistance of the heat dissipating path determines the maximum allowable device power dissipation, P_{DM} , in an application. Therefore the application's ambient temperature, T_A (°C), and thermal resistance $R_{\theta JA}$ (°C/W) must be reviewed to ensure that T_{JM} is never exceeded. Equation 1 mathematically represents the relationship and serves as the basis for establishing the rating of the part.

$$P_{DM} = \frac{(T_{JM} - T_A)}{R_{\theta JA}}$$
(EQ. 1)

In using surface mount devices such as the TO-263 package, the environment in which it is applied will have a significant influence on the part's current and maximum power dissipation ratings. Precise determination of P_{DM} is complex and influenced by many factors:

- 1. Mounting pad area onto which the device is attached and whether there is copper on one side or both sides of the board.
- 2. The number of copper layers and the thickness of the board.
- 3. The use of external heat sinks.
- 4. The use of thermal vias.
- 5. Air flow and board orientation.
- 6. For non steady state applications, the pulse width, the duty cycle and the transient thermal response of the part, the board and the environment they are in.

Fairchild provides thermal information to assist the designer's preliminary application evaluation. Figure 21 defines the $R_{\theta,JA}$ for the device as a function of the top copper (component side) area. This is for a horizontally positioned FR-4 board with 1oz copper after 1000 seconds of steady state power with no air flow. This graph provides the necessary information for calculation of the steady state junction temperature or power dissipation. Pulse applications can be evaluated using the Fairchild device Spice thermal model or manually utilizing the normalized maximum transient thermal impedance curve.

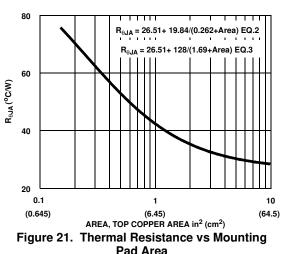
Thermal resistances corresponding to other copper areas can be obtained from Figure 21 or by calculation using Equation 2 or 3. Equation 2 is used for copper area defined in inches square and equation 3 is for area in centimeters square. The area, in square inches or square centimeters is the top copper area including the gate and source pads.

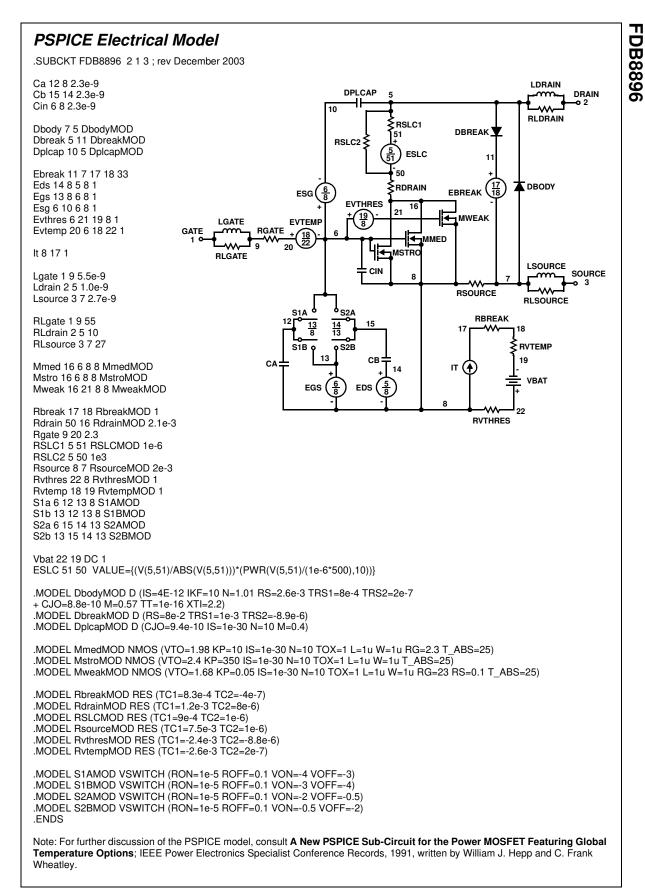
$$R_{\theta JA} = 26.51 + \frac{19.84}{(0.262 + Area)}$$
(EQ. 2)

Area in Inches Squared

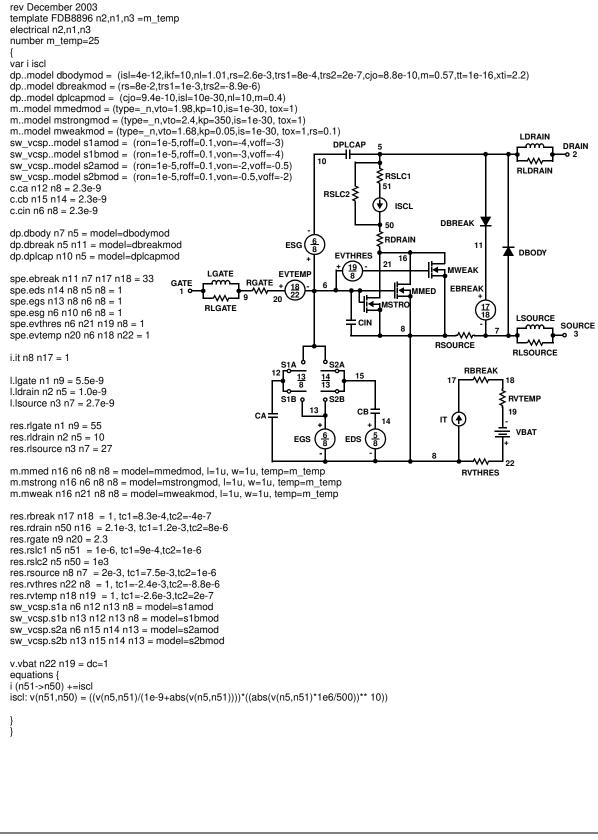
$$R_{\theta JA} = 26.51 + \frac{128}{(1.69 + Area)}$$
 (EQ. 3)

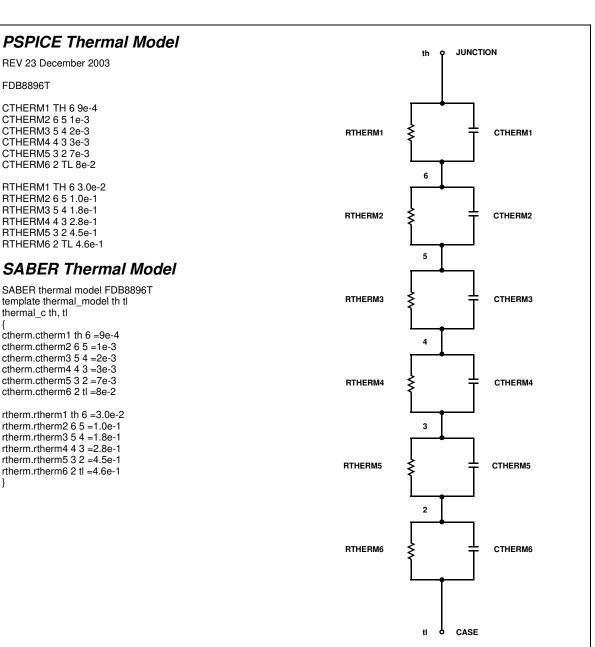
Area in Centimeters Squared





SABER Electrical Model





FDB8896T

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